September 2001



FDP6670S/FDB6670S

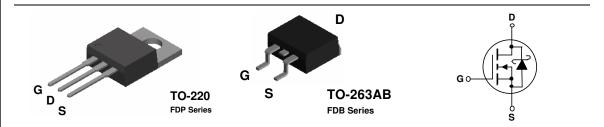
30V N-Channel PowerTrench[®] SyncFET[™]

General Description

This MOSFET is designed to replace a single MOSFET and parallel Schottky diode in synchronous DC:DC power supplies. This 30V MOSFET is designed to maximize power conversion efficiency, providing a low $R_{\text{DS}(\text{ON})}$ and low gate charge. The FDP6670S includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology. The performance of the FDP6670S/FDB6670S as the low-side switch in a synchronous rectifier is indistinguishable from the performance of the FDP6670A/FDB6670A in parallel with a Schottky diode.

Features

- 31 A, 30 V. $\begin{array}{l} R_{DS(ON)} = 8.5 \mbox{ m}\Omega \ @ \ V_{GS} = 10 \ V \\ R_{DS(ON)} = 12.5 \mbox{ m}\Omega \ @ \ V_{GS} = 4.5 \ V \end{array}$
- Includes SyncFET Schottky body diode
- Low gate charge (23nC typical)
- High performance trench technology for extremely low R_{DS(ON)} and fast switching
- High power and current handling capability



Absolute Maximum Ratings T_{A=25°C} unless otherwise noted

| Symbol | Parameter | | | Ratings | Units | |
|-----------------------------------|-------------------------------------------------------------------------------|----------------------------|-------------------|------------|-----------|--|
| V _{DSS} | Drain-Sourc | e Voltage | | 30 | V | |
| V _{GSS} | Gate-Sourc | e Voltage | ±20 | V | | |
| I _D | Drain Curre | nt – Continuous | (Note 1) | 62 | A | |
| | | Pulsed | (Note 1) | 150 | | |
| P _D | Total Powe | r Dissipation @ $T_c = 2$ | 25°C | 62.5 | W | |
| | | | Derate above 25°C | 0.5 | W/°C | |
| T _J , T _{STG} | Operating a | nd Storage Junction To | -55 to +150 | °C | | |
| TL | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | | 275 | °C | |
| Therma | l Charac | teristics | | | | |
| R _{eJC} | Thermal Re | esistance, Junction-to- | -Case | 2.1 | °C/W | |
| R _{eja} | Thermal Resistance, Junction-to-Ambient | | | 62.5 | °C/W | |
| Packag | e Markin | g and Orderin | g Information | | | |
| Device Marking | | Device | Reel Size | Tape width | Quantity | |
| FDB6670S | | FDB6670S | 13" | 24mm | 800 units | |
| FDP6670S | | FDP6670S | Tube | n/a | 45 | |
| | | | 1 | | | |

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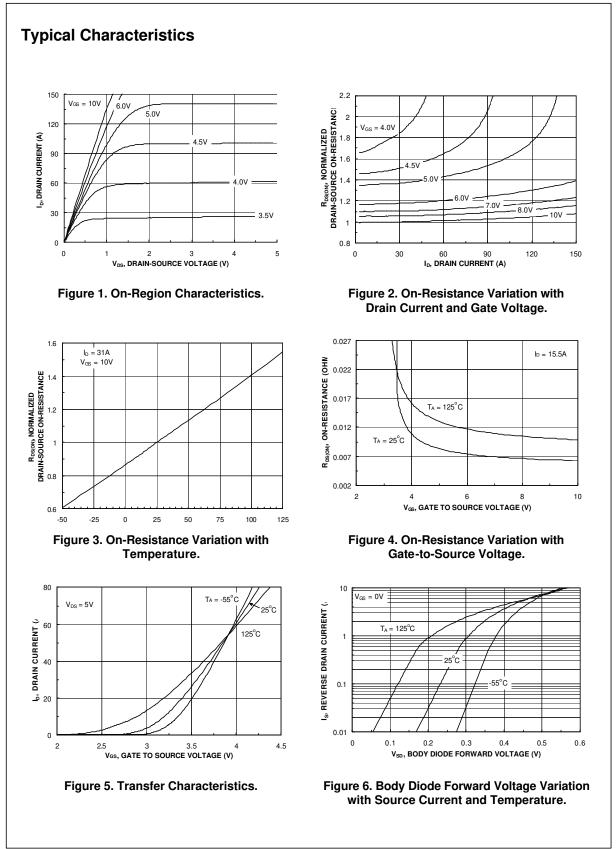
| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---------------------------------------------|---------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|--------------|-------------------|-------|
| Drain-So | Durce Avalanche Ratings (Note | 1) | | | | |
| W _{DSS} | Single Pulse Drain-Source Avalanche Energy | $V_{DD} = 25 \text{ V}, \qquad I_D = 16.5 \text{ A}$ | | | 285 | mJ |
| I _{AR} | Maximum Drain-Source Avalanche Current | ce Avalanche | | | 16.5 | А |
| Off Char | acteristics | · | • | | | |
| BV _{DSS} | Drain–Source Breakdown Voltage | $V_{GS} = 0 V$, $I_D = 1mA$ | | | | V |
| <u>ΔBV_{DSS}</u> ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = 26mA$, Referenced to 25°C | | 24 | | mV/°C |
| DSS | Zero Gate Voltage Drain Current | $V_{\text{DS}} = 24 \text{ V}, V_{\text{GS}} = 0 \text{ V}$ | | | 500 | μA |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -20 V, V_{DS} = 0 V$ | | | -100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, \qquad I_D = 1mA$ | 1 | 2.2 | 3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$ | Gate Threshold Voltage Temperature Coefficient | I_D = 26mA, Referenced to 25°C | | -4.5 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | $ \begin{array}{ll} V_{GS} = 10 \ V, & I_D = 31 \ A \\ V_{GS} = 4.5 \ V, & I_D = 26.5 \ A \\ V_{GS} = 10 \ V, \ I_D = 31 \ A, \ T_J = 125^{\circ}C \end{array} $ | | 5 8 10 | 8.5 12.5 19 | mΩ |
| I _{D(on)} | On–State Drain Current | $V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$ | 60 | | | Α |
| g _{FS} | Forward Transconductance | $V_{DS} = 10 \text{ V}, I_D = 31 \text{ A}$ | | 69 | | S |
| Dvnamic | Characteristics | | 1 | I | l. | |
| C _{iss} | Input Capacitance | $V_{DS} = 15 V$, $V_{GS} = 0 V$, | | 2639 | | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | 737 | | pF |
| Crss | Reverse Transfer Capacitance | 1 | | 222 | | pF |
| | g Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DS} = 15 V$, $I_{D} = 1 A$, | | 13 | 24 | ns |
| t _r | Turn–On Rise Time | $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | | 10 | 21 | ns |
| t _{d(off)} | Turn-Off Delay Time | - | | 39 | 62 | ns |
| t _f | Turn–Off Fall Time | 1 | | 35 | 56 | ns |
| Q _g | Total Gate Charge | $V_{DS} = 15 V$, $I_{D} = 31 A$, | | 23 | 32 | nC |
| Q _{gs} | Gate-Source Charge | $V_{GS} = 5 V$ | | 9 | | nC |
| Q _{gd} | Gate-Drain Charge | | | 8 | | nC |
| • | ource Diode Characteristics | | 1 | 1 | 1 | L |
| V _{SD} | Drain–Source Diode Forward Voltage | $ \begin{array}{ll} V_{GS} = 0 \ V, & I_S = 3.5 \ A & (\text{Note 1}) \\ V_{GS} = 0 \ V, & I_S = 7 \ A & (\text{Note 1}) \end{array} $ | | 0.39 0.48 | 0.7 0.9 | V |
| t _{rr} | Diode Reverse Recovery Time | $V_{GS} = 0.0$, $V_{S} = 7.4$ (Note 1) | | 32 | 0.0 | nS |
| Q _{rr} | Diode Reverse Recovery Charge | $d_{iF}/d_t = 300 \text{ A}/\mu \text{s}$ (Note 2) | | 56 | | nC |

Notes:

1. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

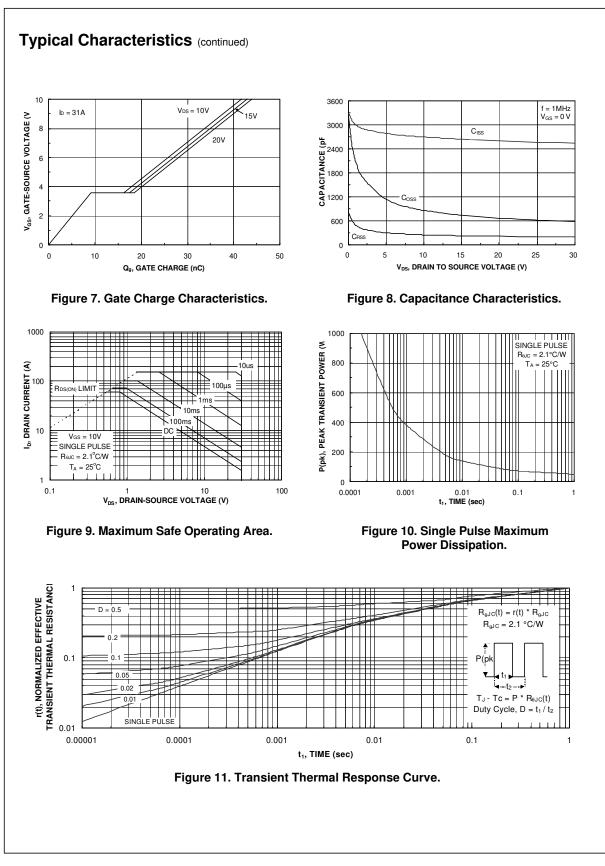
2. See "SyncFET Schottky body diode characteristics" below.

FDP6670S/FDB6670S



FDP6670S/FDB6670S

FDP6670S/FDB6670S Rev E (W)



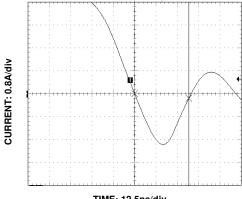
FDP6670S/FDB6670S

FDP6670S/FDB6670S Rev E (W)

Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 FDP6670S.



TIME: 12.5ns/div

Figure 12. FDP6670S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDP6670A).

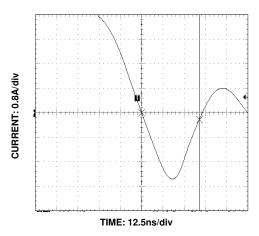
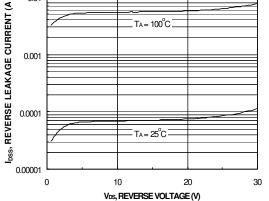


Figure 13. Non-SyncFET (FDP6670A) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

Figure 14. SyncFET diode reverse leakage

0.01 0.01 T_A = 100°C



FDP6670S/FDB6670S

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